


<b>Search Notes</b>  	<b>Application/Control No.</b>  10614738	<b>Applicant(s)/Patent Under Reexamination</b>  MITRA ET AL.
	<b>Examiner</b>  ALLAHYAR KASRAIAN	<b>Art Unit</b>  2617

SEARCHED			
Class	Subclass	Date	Examiner
370	392	10/10/2007	AK
370	400	10/10/2007	AK
370	351	10/10/2007	AK
370	238	10/10/2007	AK
370	242	10/10/2007	AK
709	238, 244	12/1/2010	AK

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Image and keyword search in USPTO, US-PGPUB, DERWENT, EPO, JPO, and IBM_TDB (see attached search strategy)	10/10/2007	AK
Inventor name and Assignee search in PALM ExPo and EAST	10/10/2007	AK
IEEE Xplore: <a href="http://ieeexplore.ieee.org/Xplore/DynWel.jsp">http://ieeexplore.ieee.org/Xplore/DynWel.jsp</a>	10/10/2007	AK
Google: <a href="http://www.google.com">http://www.google.com</a>	10/10/2007	AK
EPO Data base: <a href="http://ep.espacenet.com">http://ep.espacenet.com</a>	10/10/2007	AK
(370/392,351,352,400.ccls. 709/238,238,241,242.ccls.) and ((path link) near5 (determin\$5 estimat\$5)) and @ay<="2003"	10/10/2007	AK
Updated search	3/18/2008	AK
Updated search	9/12/2008	AK
Updated search	3/1/2009	AK
Updated search	11/13/2009	AK
Updated search	5/20/2010	AK
709/238-244.ccls. and (connect\$5 near2 request\$3) and (evaluat\$3 determin\$3 calculat\$5 examin\$5) with (path link edge) with ((source with destination) (engress ingress))	12/1/2010	AK
updated search	12/1/2010	AK
Constulated with Rafael Pérez-Gutiérrez	12/1/2010	AK
Constulated with Jinsong Hu	12/1/2010	AK

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/A. K./ Examiner: Art Unit 2617	
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